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## **TC 3700 Inventor Search Program**

See attached inventor searches for applications and/or patents to help resolve questions of overlapping subject matter. These searches are provided as an initial examination aid: examiners should perform updated or expanded PALM or EAST inventors searches as appropriate.

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### **Serial Number:**

- 1.) See attached printout of inventors listed in PALM**
  
- 2.) See attached EAST Inventor Search  
Printout shows Inventor search terms**

US 20050270490 A1	US- PGPUB	20051208	36	CORRECTION- FACTOR DETERMINATION APPARATUS AND METHOD	351/246	351/205	Mihashi, Toshifumi et al.
US 20050270484 A1	US- PGPUB	20051208	19	Portable ophthalmic apparatus and ophthalmic system	351/206		Maeda, Naoyuki et al.
US 20050219461 A1	US- PGPUB	20051006		Ophthalmological apparatus	351/205	351/221	Hirohara, Yoko
US 20050134798 A1	US- PGPUB	20050623		Device for measuring optical characteristic of eye	351/221		Hirohara, Yoko et al.
US 20050099599 A1	US- PGPUB	20050512		Eye characteristic measuring apparatus	351/205		Mihashi, Toshifumi et al.
US 20050073647 A1	US- PGPUB	20050407		Eye optical characteristic measuring instrument	351/200		Mihashi, Toshifumi et al.
US 20050046793 A1	US- PGPUB	20050303		Eye characteristic measuring apparatus	351/200		Hirohara, Yoko et al.
US 20040212781 A1	US- PGPUB	20041028		Ophthalmologic apparatus	351/221		Mihashi, Toshifumi et al.
US 20040179318 A1	US- PGPUB	20040916		Switching device	361/115		Hashimoto, Hiroaki et al.
US 20040130678 A1	US- PGPUB	20040708		Ophthalmic measuring apparatus	351/205		Hirohara, Yoko et al.
US 20040095556 A1	US- PGPUB	20040520		Contrast chart apparatus, contrast sensitivity measuring apparatus, and contrast sensitivity measuring method	351/238		Mihashi, Toshifumi et al.
US 20040080713 A1	US- PGPUB	20040429		Ophthalmic measuring apparatus	351/221		Hashimoto, Hiroaki et al.
US 20040070730 A1	US- PGPUB	20040415		Eye characteristic measuring device	351/221		Mihashi, Toshifumi et al.
US 20040012760	US- PGPUB	20040122		Eye characteristics measuring device	351/205		Mihashi, Toshifumi

A1							et al.
US 20030189690 A1	US- PGPUB	20031009		Optical characteristics measuring device	351/221		Mihashi, Toshifumi et al.
US 20030174280 A1	US- PGPUB	20030918		Model eye for eye characteristic measuring device and calibration method for the same	351/200		Yamaguchi, Tatsuo et al.
US 20030164923 A1	US- PGPUB	20030904		Best corrected visual acuity characteristics measuring device, best corrected visual acuity characteristics measuring method, contrast sensitivity measuring device, contrast sensitivity measuring method, and contrast sensitivity target displaying device	351/216		Hirohara, Yoko et al.
US 20030115596 A1	US- PGPUB	20030619		Commercial distribution system, commercial processing apparatus, commercial processing method, and commercial processing program	725/34	725/32	Okajima, Takahiro et al.
US 20030090627 A1	US- PGPUB	20030515		Ophthalmic characteristic measuring apparatus	351/211		Hirohara, Yoko et al.
US 20030043789 A1	US- PGPUB	20030306		Channel switching apparatus, channel switching method and channel switching program	370/360	370/375	Okajima, Takahiro et al.
US 20030011757 A1	US- PGPUB	20030116		OPTICAL CHARACTERISTIC MEASURING INSTRUMENT	356/6		Hirohara, Yoko et al.
US 20030007777 A1	US- PGPUB	20030109		Commercial cut apparatus, commercial cut method, recording-reproducing	386/46	358/908	Okajima, Takahiro et al.

				apparatus comprising commercial cut function, and commercial cut program			
US 20020184633 A1	US- PGPUB	20021205		Preselection apparatus, preselection method, preselection program, recorder, and recording medium	725/50	725/58	Okajima, Takahiro et al.
US 20020163623 A1	US- PGPUB	20021107		Ophthalmic characteristic measuring apparatus	351/212		Hirohara, Yoko et al.
US 20020097625 A1	US- PGPUB	20020725		Semiconductor memory device with a self refresh mode	365/222		Hashimoto, Hiroaki
US 20020041359 A1	US- PGPUB	20020411		Eye characteristic measuring apparatus	351/221		Mihashi, Toshifumi et al.
US 20010035939 A1	US- PGPUB	20011101		Eye characteristic measuring apparatus	351/212		Mihashi, Toshifumi et al.
US 7009130 B2	USPAT	20060307		Switching device	200/400	218/154	Hashimoto; Hiroaki et al.
US 6905209 B2	USPAT	20050614		Optical characteristics measuring device	351/221		Mihashi; Toshifumi et al.
US 6860603 B2	USPAT	20050301		BEST CORRECTED VISUAL ACUITY CHARACTERISTICS MEASURING DEVICE, BEST CORRECTED VISUAL ACUITY CHARACTERISTICS MEASURING METHOD, CONTRAST SENSITIVITY MEASURING DEVICE, CONTRAST SENSITIVITY MEASURING	351/216		Hirohara; Yoko et al.

				METHOD, AND CONTRAST SENSITIVITY TARGET DISPLAYING DEVICE			
US 6802609 B2	USPAT	20041012		Eye characteristic measuring apparatus	351/221		Mihashi; Toshifumi et al.
US 6695450 B2	USPAT	20040224		Ophthalmic characteristics measuring apparatus	351/211	351/221	Hirohara; Yoko et al.
US 6685320 B2	USPAT	20040203		Ophthalmic characteristic measuring apparatus	351/221	351/212	Hirohara; Yoko et al.
US 6654302 B2	USPAT	20031125		Semiconductor memory device with a self refresh mode	365/222	365/233	Hashimoto; Hiroaki
US 6629761 B1	USPAT	20031007		Eye characteristic measuring apparatus	351/221		Hirohara; Yoko et al.
US 6536900 B2	USPAT	20030325		Eye characteristic measuring apparatus	351/221		Mihashi; Toshifumi et al.
US 6525883 B2	USPAT	20030225		Optical characteristic measuring instrument	359/618	351/212	Hirohara; Yoko et al.
US 6446227 B1	USPAT	20020903		Semiconductor memory device	714/719	714/721	Hashimoto; Hiroaki
US 6378091 B1	USPAT	20020423		Test mode circuit capable of surely resetting test mode signals	714/724	714/718; 714/733	Hashimoto; Hiroaki
US 6354705 B1	USPAT	20020312		Anterior segment photographing apparatus for producing images of a section of the anterior segment of the eye to be examined by using slit light beam	351/214		Hirohara; Yoko et al.
US 6160745 A	USPAT	20001212		Semiconductor storage device	365/200	365/201	Hashimoto; Hiroaki
US 5936910 A	USPAT	19990810		Semiconductor memory device having burn-in test function	365/230.06	365/201; 365/226	Hashimoto; Hiroaki
US 5709106	USPAT	19980120		Condenser structure	62/507	62/509	Inaba;

A				with liquid tank			Hiroyuki et al.
US D361646 S	USPAT	19950822		Aquarium tank	D30/101		Hashimoto; Hiroaki
US D361170 S	USPAT	19950808		Aquarium tank	D30/101		Hashimoto; Hiroaki
US D357556 S	USPAT	19950418		Aquarium tank	D30/101		Hashimoto; Hiroaki
US D356404 S	USPAT	19950314		Aquarium tank	D30/101		Hashimoto; Hiroaki